

<b>Notice of References Cited</b>	Application/Control No. 10/567,827		Applicant(s)/Patent Under Reexamination HAIBACH ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0134191	07-2003	Buckle et al.	429/176
*	B	US-2001/0001369	05-2001	Adey et al.	72/483
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#### NON-PATENT DOCUMENTS

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